

Notice of References Cited	Application/Control No. 10/686,973		Applicant(s)/Patent Under Reexamination SAKURAI ET AL.	
	Examiner Thuy Osberg		Art Unit 2179	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,999,698 A	12-1999	Nakai et al.	386/125
*	B	US-6,166,778 A	12-2000	Yamamoto et al.	348/569
*	C	US-2002/0080160 A1	06-2002	DEVITO et al.	345/716
*	D	US-6,452,616 B1	09-2002	De Vito et al.	715/825
*	E	US-6,661,437 B1	12-2003	Miller et al.	715/810
*	F	US-7,076,734 B2	07-2006	Wolff et al.	715/720
*	G	US-6,690,290	02-2004	Young et al.	340/825.69
*	H	US-6,313,851	11-2001	Matthews et al.	715/718
*	I	US-RE39,059	04-2006	Foster, William J.	715/744
*	J	US-2002/0054146	05-2002	FUKUMOTO et al.	345/810
*	K	US-6,930,709	08-2005	Creamer et al.	348/211.3
*	L	US-6,211,870	04-2001	Foster, William	715/744
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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